Static Sublimation Purification Process and Characterization of LiZnP Semiconductor Material

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ABSTRACT

Refinement of the class $A^I B^II C^V$ materials continue as a candidate for solid-state neutron detectors. Such a device would have greater efficiency, in a compact form, than present day gas-filled ^3He and $^{10}\text{BF}_3$ detectors. The $^6\text{Li}(n,t)^4\text{He}$ reaction yields a total Q value of 4.78 MeV, larger than ^{10}B , and easily identified above background radiations. Hence, devices composed of either natural Li (nominally 7.5% ^6Li) or enriched ^6Li (usually 95% ^6Li) may provide a semiconductor material for compact high efficiency neutron detectors. A sub-branch of the III-V semiconductors, the filled tetrahedral compounds, $A^I B^II C^V$, known as Nowotny-Juza compounds, are known for their desirable cubic crystal structure. Starting material was synthesized by combining equimolar portions of Li, Zn, and P sealed under vacuum (10^{-6} Torr) in quartz ampoules, having boron nitride liners, and subsequently reacted in a compounding furnace [1]. A static vacuum sublimation in quartz was performed to help purify the synthesized material. The chemical composition of the *sublimed material* and *remaining material* was confirmed by Inductively Coupled Plasma Optical Emission Spectroscopy (ICP-OES). Lithium was not detected in the sublimed material, however, approximately stoichiometric concentrations of each constituent element were found in the remaining LiZnP material. X-ray diffraction phase identification scans of the *remains material* and *sublimed material* were compared, and further indicated the impurity materials were sublimed away from the synthesized materials. The resulting material from the sublimation process showed characteristics of a higher purity ternary compound.

INTRODUCTION

Materials containing ^6Li , ^{10}B , ^{113}Cd , ^{157}Gd or ^{199}Hg have been considered for solid-state neutron detectors [2-13]. The $^{10}\text{B}(\text{n},\alpha)^7\text{Li}$ reaction is desirable for the ^{10}B microscopic thermal neutron absorption cross section of 3839 barns, but boron-based compounds, such as BP, BN, and BAs have shown limited success, and thus far do not appear promising due to crystal growth and materials preparation problems [10-14]. Thin-film coated diode detectors suffer due to their geometry, where only one reaction product can be absorbed in semiconducting material, thereby producing some signals that can be difficult to distinguish from background and gamma-ray induced events [15]. Additionally, depending on the range of the reaction products in the boron material, film thickness is restricted, and therefore thermal neutron absorption is limited, resulting in a maximum intrinsic detection efficiency of approximately 4.5% [15]. Solid-state detectors containing ^{113}Cd and ^{199}Hg devices also have limited detection efficiency due to the low absorption probability of the prompt gamma-rays that result from the $^{113}\text{Cd}(\text{n},\gamma)^{114}\text{Cd}$ and $^{199}\text{Hg}(\text{n},\gamma)^{200}\text{Hg}$ reactions [2-5]. The reaction $^{157}\text{Gd}(\text{n},\gamma)^{158}\text{Gd}$ is desirable for the large ^{157}Gd thermal neutron capture cross section of 240,000 barns. Unfortunately, the reaction results in low energy prompt gamma rays and conversion electrons below 220 keV, mostly near 80 keV, which are difficult to discern from background radiations [15]. Finally, ^6Li has not been explored to the same extent as other thermal neutron absorbers, and has an intrinsic thermal neutron absorption cross section of 940 barns. The reaction produces a total Q-value of 4.78 MeV, seen in the following reaction,

Nowotny-Juza compounds were originally, and are still today, studied for photonic applications [16-18]. The zincblende crystal structure is arranged where the group II atom is located at $\tau_1 = (0, 0, 0)a$ where a is the lattice constant, and the group V atom is located at $\tau_2 = (1/4, 1/4, 1/4)a$. The spacious cubic structure allows for lithium atoms to fill the interstitial site at $\tau_3 = (1/2, 1/2, 1/2)a$ as shown in Fig. 1 [19, 20]. The filling of these interstitial sites allows for a lithium-loaded semiconducting material. Further, the concentration of Li atoms in the material is equal to other constituent atoms, as shown in Fig. 1. These material properties make Nowotny-Juza compounds attractive for compact, high neutron sensitivity, solid-state detectors. Difficulties in synthesis, purification, crystal growth, and handling, unfortunately limit the available physical and electrical property data [16-23]. The following study addresses the processes that are necessary for synthesizing phase pure LiZnP material in the powder form. The powders serve as important starting materials necessary for growing high-quality LiZnP crystals, that are necessary for making semiconductor based neutron detectors.

LiZnP material was synthesized in-house, in sealed, crucible-lined quartz ampoules [1, 24]. It was noticed that not all synthesis processes yielded high quality material. A multi-step synthesis was performed to yield the highest purity product, although unreacted elemental and binary materials were likely included in the synthesized material [1]. Nowotny-Juza compounds are hygroscopic, thereby, making handling quite difficult. Also, molten lithium reacts with quartz to make lithium silicates, which also narrows available purification techniques [25]. Typical non-solution based purification methods consist of: 1) dynamic vacuum sublimation, 2) static vacuum sublimation, 3) vacuum distillation, and 4) zone refining. Vacuum distillation is typically performed on elemental materials, or compounds, that do not sublime before becoming molten [26, 27]. LiZnP melts slightly above 1300 °C, and sublimates before becoming molten, therefore a distillation method is not appropriate. Additionally, due to the high melting temperature,

traditional zone refining is not a trivial process. A static vacuum sublimation was chosen over dynamic vacuum sublimation due to little concern of $A^I B^{II} B^V$ material exposure to the atmosphere in the handling process. Sublimation is a clean and effective way to purify elemental and compounded materials, as shown with many materials [28-30]. Synthesized ternary material was processed through a static vacuum sublimation that significantly helped reduced the material impurity level.

EXPERIMENTAL DETAILS

The following sections entail the sublimation process of LiZnP, and the ICP-OES and XRD characterization that verify the process results.

I. Sublimation Process

LiZnP was synthesized, as explained elsewhere [1], in batches up to 2.0 grams. Approximately 5.0g of LiZnP was added to a boron nitride crucible boat, and loaded into one side of a clean, thick wall ($>2.5\text{mm}$) quartz ampoule as shown in Fig. 2. The ampoule was removed from the argon atmosphere while remaining under argon by a closed vacuum attachment. The ampoule was placed on a vacuum sealing station, where it was baked out to remove residual moisture, and evacuated to approximately 9.8×10^{-6} Torr, subsequently sealed using a $\text{H}_2\text{-O}_2$ torch. The ampoule was placed into a three zone furnace, where two zones were ramped to 750°C for LiZnP purification, and the third zone was ramped to 550°C . The ampoule was also mounted in the furnace so that the *cold* end of the ampoule extended to the edge of the furnace as shown in Fig. 3.

Samples from each side of the ampoule were collected, one from the *sublimed* material, and one from the *remains* after purification. The samples were analyzed by elemental analysis on a Varian 720-ES Inductively Coupled Plasma Optical Emission Spectroscopy (ICP-OES) instrument. This method uses simultaneous optical systems, and axial or radial viewing of the plasma to measure characteristic emission spectra by optical spectroscopy. Note, that this particular elemental analysis has been known to have up to a 10% relative standard deviation about the measured elemental weight [31]. However, with careful preparation of the calibration standards, and samples, this relative error can be reduced.

Phase identification x-ray diffraction scans were collected on a Bruker D8 ADVANCE, equipped with Cu radiation, using the Bragg Brentano geometry. A sample from the *sublimed material*, and *remains material* was harvested from the respective side of the purification ampoule, and ground into a fine powder using a clean mortar and pestle. Each powder was loaded into a zero-background sample holder with a layer of Biaxially-oriented polyethylene terephthalate (BoPET), known as Mylar®, over the top of the material, and sealed for protection from moisture in air. A phase identification scan was collected for both samples. The results were compared with theoretical phase locations calculated with PowderCell 2.4, and data presented in the literature [17, 22].

II. ICP-OES process

Standard solutions of varying concentrations (0, 1, 3, and 5 mg/L – Li; 0, 15, 30, 50, and 70 mg/L – Zn; 0, 10, 20, 30, and 40 mg/L – P) in water were prepared, and measured on a Varian 720-ES ICP-OES instrument to establish concentration curves. Percent deviation, or error, from the expected concentration of each standard solution was determined by the instrument, the results of which, can be found in Table 1. The *LiZnP remains material* and *sublimed material* were prepared for ICP-OES analysis. Each 100mg sample was loaded into a pyrex sample container under argon, and sealed with Parafilm[®] to reduce air exposure when removed from the glove box. In a fume hood, the Parafilm[®] was removed, and 10mL of freshly prepared aqua regia (1:4 volumetric ratio HNO₃/HCl) was quickly added to each sample. The remains side of LiZnP purification produced a noticeable reaction that produced a black vapor with the addition of aqua regia. The addition of aqua regia to the deposition side did not produce a noticeable reaction. The digestion was allowed to continue overnight.

Most of the material had dissolved in each sample vial after a 24 hour period. To ensure complete digestion of the remaining material, each vial was heated on a digestion block at 75°C for 30 min, 100°C for 30 min, 110°C for 30 min, and 140°C until the acid was reduced to approximately 2.0mL [32]. Each solution was removed from the digestion block and was increased to a 50 mL solution using 0.1% HNO₃. Each 50mL solution was then filtered through a Whatman[®] no. 42 filter paper. A 2.5 mL sample from each filtrate was diluted a second time to 50mL, to acquire a solution possessing less than 100 mg/L of each element of interest. Some sample solutions still exceeded detection limits of the ICP-OES instrument, so further dilution by 25% or 50% was required. Two measurements were collected for each sample.

The analysis results are listed in Table 2. The percent result of each constituent element was based on the instrument analysis of the concentration of the particular element, and the total amount of material originally weighted for analysis. The elemental percent concentrations were then converted to molar concentration using each element's molar mass. The analysis percent error, and molar concentration standard error were determined based on the deviation from the average of the two measurements for each sample, and the systematic error associated with the concentration curves determined by the ICP-OES instrument.

RESULTS AND DISCUSSION

Static vacuum sublimation of the in-house synthesized powders and chunks of LiZnP appeared to produce a higher purity ternary material. Listed in Table 2 are the ICP-OES results for a LiZnP purification collected on a Varian 720-ES Inductively Coupled Plasma Optical Emission Spectrometer. Li was only slightly present in the *sublimed material* sample with a concentration of < 0.1%. The *remains material* kept the stoichiometric ratios desired for A^IB^{II}C^V materials with a Li concentration of 13.05 ± 0.09 %. Furthermore, the total weight percent of each *remains material* element equaled 100% within the propagated total 3.3% error from the three elemental measurements. Additionally, each elemental constituent molar concentration is approximately equal within the standard deviation. These results further indicate that impurities (binaries, unreacted elemental components) were transferred out of the in-house synthesized material during the sublimation process, leaving a much purer ternary material.

The theoretical phase identification for LiZnP is shown in Fig. 5, as calculated using PowderCell 2.4 [33]. The X-ray diffraction phase identification results of the *sublimed material* and *remains material* are shown in Fig. 6 and 7 respectively. The *sublimed material* did not indicate a significance of phase peaks, except for a single orientation, making it difficult to

181 identify. However, the *remains material* phase identification, shown in Fig 7, showed an
182 arrangement of peaks that match with what is presented in literature [17, 22] and from what was
183 theoretically calculated (Fig. 5). A lattice constant was determined using TOPAS (Bruker AXS
184 Inc.). The Whole Pattern decomposition approach was used. Refinement of the *remains material*
185 phase identification data yielded a lattice constant of $5.786 \pm .002 \text{ \AA}$ which was consistent to
186 what was reported from raw synthesized (unpurified) material [1].

187 The *remains material* phase identification, Fig. 7, clearly showed the (111), (220), (222)
188 (331) (422) and (511) LiZnP orientations. In addition preferred orientation along the (220) LiZnP
189 is observed. However, the (200), (311), (400) and (420) orientations are not recorded. The (200),
190 (400) and (420) LiZnP orientations do have weak reflections, as seen in Fig. 5, and therefore, can
191 be difficult to measure. Additional peaks were also observed near the (111) and (331) LiZnP
192 orientations which could be due to secondary phases created as a result of oxidation during
193 handling and measurement. The material was encapsulated under argon during the measurement,
194 and degradation could have occurred over time due to leakage of air into the encapsulant.
195 Additionally there is also the possibility of the presence of a secondary LiZnP phase with a
196 slightly different lattice constant. Ultimately, the static sublimation process appeared to help
197 clean the LiZnP material of unreacted metals, or other impurities, as clearly shown by
198 comparison between Fig. 6 and 7.
199

200 CONCLUSIONS

201
202 Nowotny-Juza compounds were synthesized in-house into powder and chunks, and
203 purified by a static sublimation. The ICP-OES data indicate that higher vapor pressure binary
204 and elemental materials can be removed from the synthesized material reducing the impurity
205 level, while retaining the 1:1:1 stoichiometric ratio between constituent elements. The
206 purification material x-ray diffraction studies also indicate that impurities were removed.
207 However, phase peaks still exist that cannot be identified. Some peaks may belong to a binary or
208 elemental material that was included from one or a few of the five total LiZnP synthesis
209 processes that were used in the sublimation process. Additionally, the thermal profile may have
210 to be explored further to optimize the sublimation process. Ultimately, a higher quality material
211 was produced, and will be used to grow crystalline ingots that can be processed into devices.
212 Finally, electrical properties (resistivity, electron mobility) and neutron sensitivity will be
213 characterized from these devices.
214
215
216

• Li • Group II • Group V

Fig. 1. The Nowotny-Juza filled tetrahedral zincblende cubic crystal structure

Sublimate: Ambient
Temperature

Remains: 750 °C

Fig. 2. Diagram of the static sublimation ampoule

Fig. 3. Ampoule of $A^I B^{II} C^V$ material prepared for a static sublimation process.

Fig. 4. Ampoule of LiZnP after static sublimation process. a) The remains end of the ampoule b) The sublimed portion of the ampoule.

Table 1. The standard solution percent errors, or deviations, from the expected concentrations. Negative values indicates the concentration deviation lies below the expected value.

Element	Concentration (mg/L)	% Error
Li	0	0
	1	5.116
	3	0.554
	5	-0.404
Zn	0	0
	15	7.151
	30	8.493
	50	3.184
P	0	0
	10	0.356
	20	0.813
	30	-0.404
	40	0.002

Table 2. The ICP-OES results of LiZnP post static sublimation collected on a Varian 720-ES.

Sample: Remains (Purified)			Sample: Sublimate (Elemental, binary)		
Analysis	Result (Weight %)	Molar concentration (mol/L)	Analysis	Result (Weight %)	Molar concentration (mol/L)
P	33.0 ± 0.4	0.001011 ± 0.000004	P	23.0 ± 0.3	0.000780 ± 0.000003
Li	13.05 ± 0.09	0.001786 ± 0.000002	Li	<0.1	
Zn	54.3 ± 2.8	0.00079 ± 0.00002	Zn	85.6 ± 2.3	0.001375 ± 0.000004
Total	100.4 ± 3.3

Fig. 5. The theoretical Cu x-ray phase identification of LiZnP. Calculated using PowderCell 2.4 [33]. A $5.751 \pm .001$ Å lattice constant and F-43m space group was used in the calculation as reported elsewhere [1].

Fig. 6. LiZnP *sublimed material* phase identification scan collected on a Bruker AXS D8 ADVANCE equipped with Cu radiation, using the Bragg Brentano geometry.

Fig. 7. LiZnP *remains material* phase identification scan collected on a Bruker AXS D8 ADVANCE equipped with Cu radiation, using the Bragg Brentano geometry. The black vertical dotted lines are experimental peaks found by Bacewicz [22].

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Table(s)

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